

REPORT NO. JP/2023/030113 DATE: March 152023

Tower Partn ers Semiconductor Co, Ltd.(TPSCo)

800 HIG ASHIYAMA UOZU-CITY TOYAMA JAPAN

SAMPLE NAME : Manufactured silicon wafer(200mm, at Tonami)

**CLIENT REF.NO** 

THE ABOVE SAMPLE(S) AND INFORMATION WERE PROVIDED BY THE APPLICANT.

上記のサンプル並びに情報は顧客により提供されました。

SAMPLE RECEIVED サンプル受領日

: 2023/03/03

**TESTING DATE** 

分析期間

: 2023/03/03TO 2023/03/13

**TEST REQUESTED** 

分析項目

: SELECTED TEST(S) AS REQUESTED BY CLIENT.

分析項目は顧客の要求によります。

TEST METHOD(S)

分析方法

WTH REFERENCE TO LATEST EDITIO NO FIEC62321FOR ROHS 10 SUBSTANCES.

O THER CHEMICALS WERE TESTED BY EACH APPROPRIATE METHOD.

RoHS10物質の分析は最新版のIEC62321 参照しました。

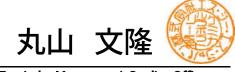
それ以外の化学物質についてはそれぞれに最適な方法で分析を行いました。

TEST RESULT(S)

分析結果

: PLEASE REFER TO THE NEXT PAGE(S).

以下のページをご参照願います。



Fumitaka Maruyama / Quality Officer Central Chemical Laboratory SGS Japan Inc.

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PAGE: 1 OF 9



REPORT NO. JP/2023/030113

DATE :M arch 15,2023

PAGE: 2 OF 9

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#### **TEST RESULT(S)**

ITEM(S)	UNIT	RESULT	METHOD	INST./PLACE	MDL
C ADMIUM(Cd)	mg/kg	N.D.	IEC62321-52013	IC P-OES	2
LEAD(Pb)	mg/kg	N.D.	IEC62321- <b>∑</b> 013	IC P-OES	2
MERCURY(H g	mg/kg	ND.	IEC62321-42013+AMD1: 2017	IC P-OES	2
C HROMIU MVI(C r(V I))	mg/kg	N.D.	IEC62321-7-22017	UV-MS*	8
Polybrominated biphenyls(PBBs)					
Monobomobiphenyl	mg/kg	N.D.	IEC62321− <b>&amp;</b> 015	GC/MS*	5
D ibromobiphenyl	mg/kg	N.D.			5
T ribromobiphenyl	mg/kg	N.D.			5
Tetrabromobiphenyl	mg/kg	N.D.			5
Pentabromobiphenyl	mg/kg	N.D.			5
H exabromobiphenyl	mg/kg	ND.			5 5
Heptabromobiphenyl	mg/kg	N.D.			5
O ctabromobipheny	mg/kg	N.D.			5 5
N onabromobiphenyl	mg/kg	N.D.			5
D ecabromobiphenyl	mg/kg	N.D.			5
Polybrominated diphenyl ethers(PBDEs)					
Monobomodiphenyl ether	mg/kg	N.D.	IEC62321− <b>@</b> 015	GC/MS*	5
D ibromodiphenyl ether	mg/kg	N.D.			5 5
T ribromodiphenyl ether	mg/kg	N.D.			5
Tetrabromodiphenyl ether	mg/kg	N.D.			5
Pentabromodiphenyl ether	mg/kg	N.D.			
H exabromodiphenyl ether	mg/kg	ND.			5 5 5 5
Heptabromodphenyl ether	mg/kg	N.D.			5
O ctabromodiphenyl ether	mg/kg	N.D.			5
N onabromodiphenyl ether	mg/kg	N.D.			5
D ecabromodiphenyl ether	mg/kg	N.D.			5
A NTIMONY(Sb)	mg/kg	N.D.	EPA3052	IC P-OES	2
ARŒNIC (As)	mg/kg	N.D.	EPA3052	IC P-OES	10
B ERYLLIUM(Be)	mg/kg	N.D.	EPA3052	IC P-OES	10
HALOGEN					
FLUORIN E(F)	mg/kg	ND.	BS EN14582@016) Combustion	IC*	50
C HLORIN E(CI)	mg/kg	N.D.	BS EN145820016) Combustion	IC*	50
B ROMINE(Br)	mg/kg	N.D.	BS EN145820016) Combustion	IC*	50
IO DIN E(I)	mg/kg	N.D.	BS EN145820016) Combustion	IC*	50
H EXAB ROMOCYCLODODECAN E(H B @D)	mg/kg	ND.	IEC62321-92021	GC/MS*	20
PHTHALATES					
D ISOB U TYL PH TH ALATE(DIB P)	mg/kg	ND.	IEC62321-& 017	GC/MS*	50

N OTES:mg/kg=ppm,N.D=N otD etected,I N ST.=I N STRU MEN T, MDL = Method Detection Limit

REMARK Tested the sample which was hard to be disjointed mechanically.

D eviation was foundin sample composition.

<sup>\* =</sup> The test has been conducted in association with SGS Taiw an Ltd.



REPORT NO. JP/2023/030113

DATE :M arch 15,2023

PAGE: 3 OF 9

Tower Partners Semiconductor Co, Ltd.(T PSCo)

800 HIG ASHIYAMA UOZU-CITY TOYAMA JAPAN

#### **TEST RESULT(S)**

ITEM(S)	UNIT	RESULT	METHOD	INST./PLACE	MDL
D BUTYL PHTHALATE(DBP)	mg/kg	N.D.	IEC62321-& 017	GC/MS*	50
BUTYLBEN ZYL PHTHALATE(BBP)	mg/kg	ND.	IEC62321-& 017	GC/MS*	50
D (2-ETH YLH EXYL) PH TH ALATE(DEHP)	mg/kg	N.D.	IEC62321-& 017	GC/MS*	50
PERFLUO RO O (TANE SULFO NATES (PFO S)	mg/kg	N.D.	EPA3550C	LC/MS/MS*	10
PERFLUO RO O (TANO C ACID (PFOA)	mg/kg	N.D.	EPA3550C	LC/MS/MS*	10

NOTES:mg/kg=ppm,N.D=NotDetected,INST.=INSTRUMENT, MDL=MethodDetectionLimit

REMARK Tested the sample which was hard to be disjointed mechanically.

Deviation was foundin sample composition.

<sup>\* =</sup> The test has been conducted in association with SGS Taiw an Ltd.



REPORT NO. JP/2023/030113

DATE :March 152023

PAGE: 4 OF 9

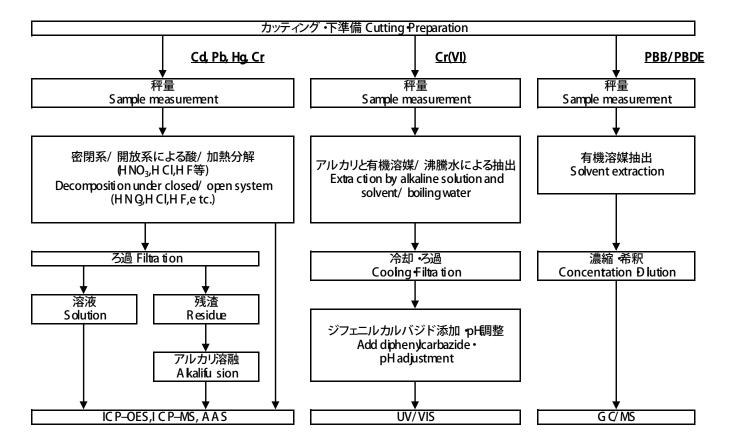
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800 HIG ASHIYAMA UOZU-CITY TOYAMA JAPAN

#### 分析フローチャートMEASUREMENT FLOW CHART

酸分解前処理において試料を完全分解しています。

The sample was dissolved/decomposed totally by acid pre-conditioning method according to below flow chart.



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REPORT NO. JP/2023/030113

DATE: March 152023

PAGE: 5 OF 9

Tower Partners Semiconductor Co, Ltd.(TPSCo)

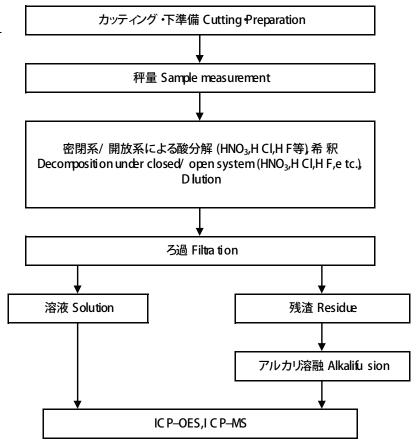
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The sample was dissolved/decomposed totally by acid pre-conditioning method according to below flow chart.

#### <u>無機分析</u> INORGANIC ANALYSIS





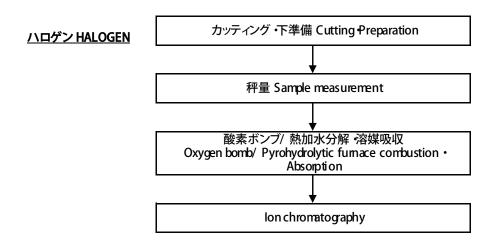
REPORT NO. JP/2023/030113

DATE :March 15,2023

PAGE: 6 OF 9

Tower Partners Semiconductor Co, Ltd.(TPSCo) 800 HIG ASHIYAMA UOZU-CITY TOYAMA JAPAN

#### 分析フローチャートMEASUREMENT FLOW CHART





REPORT NO. JP/2023/030113

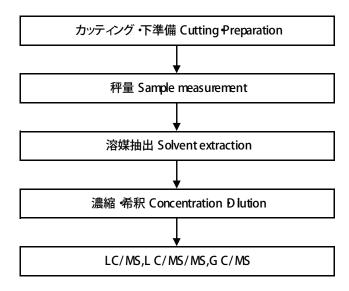
DATE :March 15,2023

PAGE: 7 OF 9

Tower Partners Semiconductor Co, Ltd.(TPSCo) 800 HIG ASHIYAMA UOZU-CITY TOYAMA JAPAN

#### 分析フローチャートMEASUREMENT FLOW CHART

#### **PERFLUORINATED** COMPOUNDs(PFCs)





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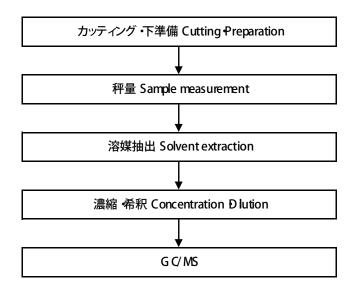
PAGE: 8 OF 9

Tower Partners Semiconductor Co, Ltd.(TPSCo)

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#### 分析フローチャートMEASUREMENT FLOW CHART

#### <u>フタル酸エステル</u> **PHTHALATES**





REPORT NO. JP/2023/030113

DATE :M arch 15,2023

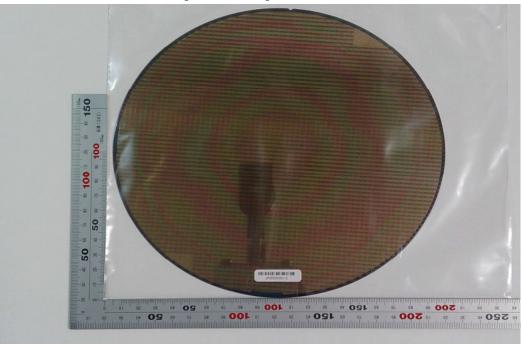
PAGE: 9 OF 9

Tower Partners Semiconductor Co, Ltd.(TPSCo)

800 HIG ASHIYAMA UOZU-CITY TOYAMA JAPAN

#### **SAMPLE IMAGE**

# JP/2023/030113



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